

Search Notes

Application/Control No.

10/664,097

Examiner

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Applicant(s)/Patent under
Reexamination

JENSEN ET AL.

Art Unit

2863

SEARCHED

Class	Subclass	Date	Examiner
702	62, 61	3/16/2005	VXH
	64, 90		
	60		
324	110		
	74-77		
	140R, 141		
	142		
340	657, 658		
	660, 661		

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST	3/16/2005	VXH